

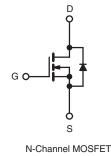
K1318-VB Datasheet N-Channel 100-V (D-S) MOSFET

PRODUCT SUMMARY						
V _{DS} (V)	100					
R _{DS(on)} (Ω)	V _{GS} = 10 V	0.086				
Q _g (Max.) (nC)	72					
Q _{gs} (nC)	11					
Q _{gd} (nC)	32					
Configuration	Single					

FEATURES

- Isolated Package
- High Voltage Isolation = 2.5 kV_{RMS} (t = 60 s; f = 60 Hz)
- Sink to Lead Creepage Distance = 4.8 mm
- 175 °C Operating Temperature
- Dynamic dV/dt Rating
- Low Thermal Resistance
- Lead (Pb)-free Available





	C = 20 0, u				1	
PARAMETER			SYMBOL	LIMIT	UNIT	
Drain-Source Voltage			V _{DS}	100	v	
Gate-Source Voltage			V _{GS}	± 20		
Continuous Drain Current	V _{GS} at 10 V	T _C = 25 °C	I _D	18		
	VGS at 10 V	T _C = 100 °C		12	A	
Pulsed Drain Currenta			I _{DM}	68	1	
Linear Derating Factor				0.32	W/°C	
Single Pulse Avalanche Energy ^b			E _{AS}	720	mJ	
Repetitive Avalanche Current ^a			I _{AR}	17	A	
Repetitive Avalanche Energy ^a			E _{AR}	4.8	mJ	
Maximum Power Dissipation	T _C = 25 °C		PD	48	W	
Peak Diode Recovery dV/dt ^c			dV/dt	5.5	V/ns	
Operating Junction and Storage Temperature Range		T _J , T _{stg}	- 55 to + 175	°C		
Soldering Recommendations (Peak Temperature)	for	10 s		300 ^d		
Mounting Torque	6-32 or M3 screw			10	lbf ⋅ in	
				1.1	N · m	

Notes

a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).

b. $V_{DD} = 25 \text{ V}$, starting $T_J = 25 \text{ °C}$, L = 3.7 mH, $R_G = 25 \Omega$, $I_{AS} = 17 \text{ A}$ (see fig. 12). c. $I_{SD} \le 17 \text{ A}$, dl/dt $\le 200 \text{ A}/\mu\text{s}$, $V_{DD} \le V_{DS}$, $T_J \le 175 \text{ °C}$.

d. 1.6 mm from case.



COMPLIANT



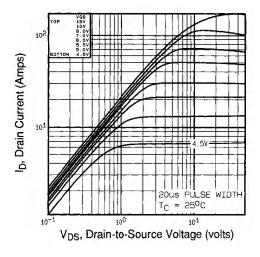
THERMAL RESISTANCE RAT	TINGS								
PARAMETER	SYMBOL	TYP.		MAX.		UNIT			
Maximum Junction-to-Ambient	R _{thJA}	- 65				°C ///			
Maximum Junction-to-Case (Drain)	R _{thJC}	- 3.1				°C/W			
SPECIFICATIONS $T_J = 25 \ ^{\circ}C$,		1							
PARAMETER	SYMBOL	TES	T CONDITI	ONS	MIN.	TYP.	MAX.	UNIT	
Static					1	1	[
Drain-Source Breakdown Voltage	V _{DS}		= 0 V, I _D = 2	-	100	-	-	V	
V _{DS} Temperature Coefficient	$\Delta V_{DS}/T_{J}$	Referenc	e to 25 °C,	$I_D = 1 \text{ mA}$	-	0.13	-	V/°C	
Gate-Source Threshold Voltage	V _{GS(th)}	V _{DS} =	V_{GS} , $I_D = 2$	250 μΑ	1.0	-	3.0	V	
Gate-Source Leakage	I _{GSS}	\	$V_{GS} = \pm 20 \text{ V}$			-	± 100	nA	
Zero Gate Voltage Drain Current	1000	V _{DS} =	$V_{DS} = 100 \text{ V}, \text{ V}_{GS} = 0 \text{ V}$		-	-	25	μA	
Zero dale Volage Diali Guiten	I _{DSS}	V _{DS} = 80 V,	$V_{GS} = 0 V,$	$T_J = 150 \ ^\circ C$	-	-	250	μΑ	
Drain-Source On-State Resistance	R _{DS(on)}	$V_{GS} = 10 V$	I _D	= 10 A ^b	-	0.086	-	Ω	
Forward Transconductance	9 _{fs}	V _{DS} =	= 50 V, I _D =	10 A ^b	9.1	-	-	S	
Dynamic									
Input Capacitance	C _{iss}	V _{GS} = 0 V, V _{DS} = 25 V, f = 1.0 MHz, see fig. 5 f = 1.0 MHz			-	1700	-		
Output Capacitance	C _{oss}			-	560	-	рF		
Reverse Transfer Capacitance	C _{rss}			-	120	-			
Drain to Sink Capacitance	С			-	12	-			
Total Gate Charge	Q _g				-	-	72		
Gate-Source Charge	Q _{gs}	V _{GS} = 10 V	I _D = 17 /	7 A, $V_{DS} = 80 V$,	-	-	11	nC	
Gate-Drain Charge	Q _{gd}	$v_{GS} = 10 v$ see fig. 6 ar		. 6 and 13 ⁵	-	-	32	1	
Turn-On Delay Time	t _{d(on)}				-	11	-		
Rise Time	t _r	$\begin{split} V_{DD} &= 50 \text{ V}, \text{ I}_{D} = 17 \text{ A}, \\ R_{G} &= 9.1 \ \Omega, \text{ R}_{D} = 2.9 \ \Omega, \\ &\text{see fig. } 10^{b} \end{split}$		-	44	_	ns		
Turn-Off Delay Time	t _{d(off)}			_	53	_			
Fall Time	t _f				43	-			
Internal Drain Inductance	L _D	Between lead, 6 mm (0.25") from package and center of die contact			4.5	_	nH		
	ĽD				ч.5				
Internal Source Inductance	LS			-	7.5	-			
Drain-Source Body Diode Characteristic	s	1					I	I	
Continuous Source-Drain Diode Current	I _S	MOSFET symbol showing the integral reverse p - n junction diode		-	-	17	A		
Pulsed Diode Forward Current ^a	I _{SM}			-	-	68			
Body Diode Voltage	V _{SD}	$T_J = 25 \text{ °C}, I_S = 17 \text{ A}, V_{GS} = 0 \text{ V}^{b}$		-	-	2.5	V		
Body Diode Reverse Recovery Time	t _{rr}	$T_J = 25 \text{ °C}, I_F = 17 \text{ A}, dl/dt = 100 \text{ A}/\mu\text{s}^b$		-	180	360	ns		
Body Diode Reverse Recovery Charge	Q _{rr}			-	1.3	2.6	μC		
Forward Turn-On Time	t _{on}	Intrinsic turn-on time is negligible (turn-on is dominated by L_S and L_D)						_n)	

Notes

a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).

b. Pulse width \leq 300 µs; duty cycle \leq 2 %.





TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted



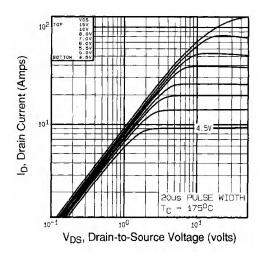


Fig. 2 - Typical Output Characteristics, $T_C = 175 \ ^\circ C$

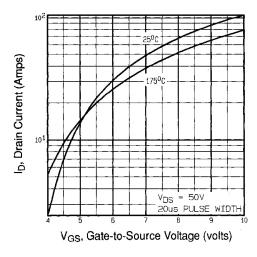


Fig. 3 - Typical Transfer Characteristics

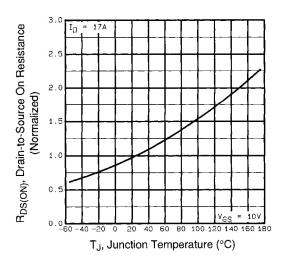


Fig. 4 - Normalized On-Resistance vs. Temperature

K1318-VB



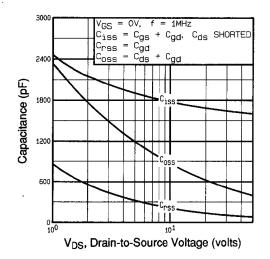


Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage

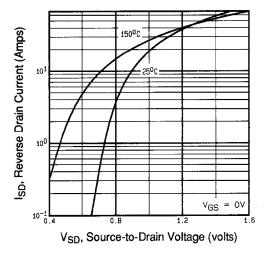


Fig. 7 - Typical Source-Drain Diode Forward Voltage

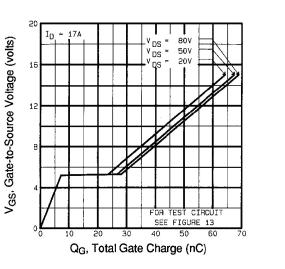


Fig. 6 - Typical Gate Charge vs. Gate-to-Source Voltage

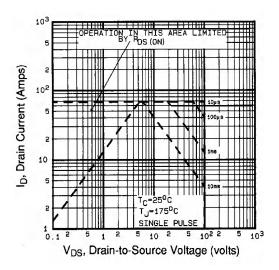


Fig. 8 - Maximum Safe Operating Area



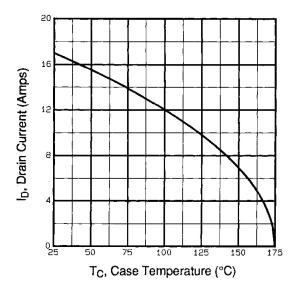


Fig. 9 - Maximum Drain Current vs. Case Temperature

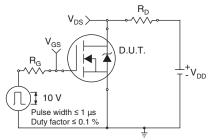


Fig. 10a - Switching Time Test Circuit

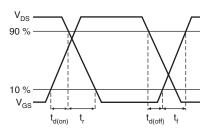


Fig. 10b - Switching Time Waveforms

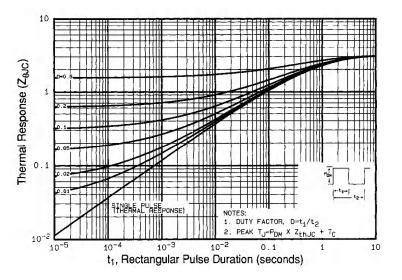


Fig. 11 - Maximum Effective Transient Thermal Impedance, Junction-to-Case

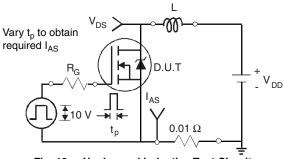


Fig. 12a - Unclamped Inductive Test Circuit

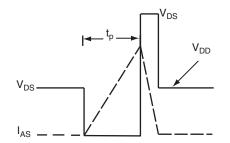


Fig. 12b - Unclamped Inductive Waveforms



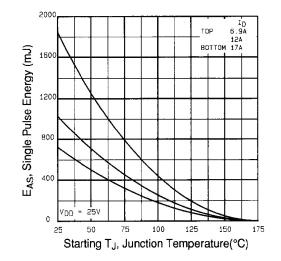


Fig. 12c - Maximum Avalanche Energy vs. Drain Current

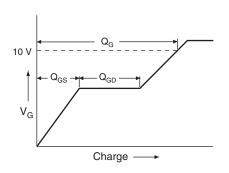
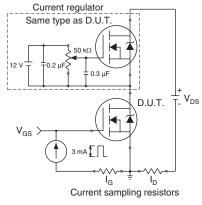
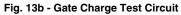
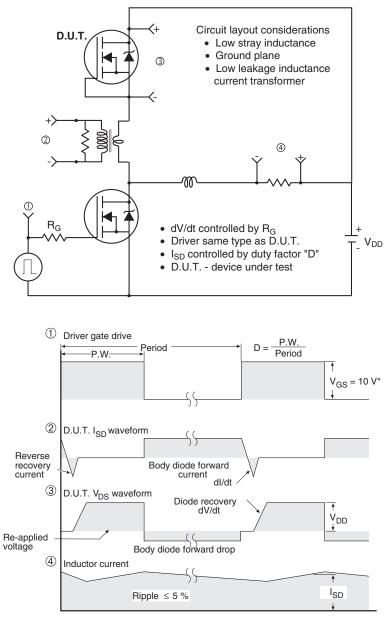


Fig. 13a - Basic Gate Charge Waveform









Peak Diode Recovery dV/dt Test Circuit

* V_{GS} = 5 V for logic level devices

Fig.14 - For N-Channel



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